

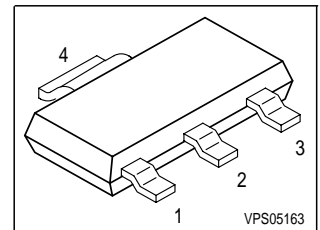
## SIPMOS® Small-Signal-Transistor

### Features

- N-Channel
- Enhancement mode
- Avalanche rated
- Logic Level
- dv/dt rated

### Product Summary

|                                  |              |      |          |
|----------------------------------|--------------|------|----------|
| Drain source voltage             | $V_{DS}$     | 60   | V        |
| Drain-Source on-state resistance | $R_{DS(on)}$ | 0.09 | $\Omega$ |
| Continuous drain current         | $I_D$        | 2.6  | A        |



| Type    | Package | Ordering Code |
|---------|---------|---------------|
| BSP318S | SOT-223 | Q67000-S4002  |

| Pin 1 | Pin 2, 4 | PIN 3 |
|-------|----------|-------|
| G     | D        | S     |

### Maximum Ratings, at $T_j = 25\text{ °C}$ , unless otherwise specified

| Parameter   | Symbol              | Value       | Unit               |
|---|---------------------|-------------|--------------------|
| Continuous drain current  | $I_D$               | 2.6         | A                  |
| Pulsed drain current<br>$T_A = 25\text{ °C}$  | $I_{D\text{ puls}}$ | 10.4        |                    |
| Avalanche energy, single pulse<br>$I_D = 2.6\text{ A}$ , $V_{DD} = 25\text{ V}$ , $R_{GS} = 25\ \Omega$                                   | $E_{AS}$            | 60          | mJ                 |
| Avalanche current, periodic limited by $T_{jmax}$   | $I_{AR}$            | 2.6         | A                  |
| Avalanche energy, periodic limited by $T_{jmax}$  | $E_{AR}$            | 0.18        | mJ                 |
| Reverse diode dv/dt<br>$I_S = 2.6\text{ A}$ , $V_{DS} = 20\text{ V}$ , $di/dt = 200\text{ A}/\mu\text{s}$ ,<br>$T_{jmax} = 150\text{ °C}$ | dv/dt               | 6           | kV/ $\mu\text{s}$  |
| Gate source voltage   | $V_{GS}$            | $\pm 20$    | V                  |
| Power dissipation<br>$T_A = 25\text{ °C}$   | $P_{tot}$           | 1.8         | W                  |
| Operating and storage temperature   | $T_j, T_{stg}$      | -55... +150 | $^{\circ}\text{C}$ |
| IEC climatic category; DIN IEC 68-1   |                     | 55/150/56   |                    |

**Thermal Characteristics**

| Parameter   | Symbol     | Values |          |         | Unit |
|---|------------|--------|----------|---------|------|
|   |            | min.   | typ.     | max.    |      |
| <b>Characteristics</b>  |            |        |          |         |      |
| Thermal resistance, junction - soldering point<br>(Pin 4)   | $R_{thJS}$ | -      | 17       | -       | K/W  |
| SMD version, device on PCB:<br>@ min. footprint<br>@ 6 cm <sup>2</sup> cooling area <sup>1)</sup> | $R_{thJA}$ | -<br>- | 100<br>- | -<br>70 |      |

**Electrical Characteristics, at  $T_j = 25\text{ °C}$ , unless otherwise specified**

| Parameter  | Symbol        | Values |          |          | Unit          |
|--|---------------|--------|----------|----------|---------------|
|  |               | min.   | typ.     | max.     |               |
| <b>Static Characteristics</b>  |               |        |          |          |               |
| Drain- source breakdown voltage<br>$V_{GS} = 0\text{ V}$ , $I_D = 0.25\text{ mA}$  | $V_{(BR)DSS}$ | 60     | -        | -        | V             |
| Gate threshold voltage, $V_{GS} = V_{DS}$<br>$I_D = 20\text{ }\mu\text{A}$   | $V_{GS(th)}$  | 1.2    | 1.6      | 2        |               |
| Zero gate voltage drain current<br>$V_{DS} = 60\text{ V}$ , $V_{GS} = 0\text{ V}$ , $T_j = 25\text{ °C}$<br>$V_{DS} = 60\text{ V}$ , $V_{GS} = 0\text{ V}$ , $T_j = 150\text{ °C}$ | $I_{DSS}$     | -<br>- | 0.1<br>- | 1<br>100 | $\mu\text{A}$ |
| Gate-source leakage current<br>$V_{GS} = 20\text{ V}$ , $V_{DS} = 0\text{ V}$  | $I_{GSS}$     | -      | 10       | 100      | nA            |
| Drain-Source on-state resistance<br>$V_{GS} = 4.5\text{ V}$ , $I_D = 2.6\text{ A}$   | $R_{DS(on)}$  | -      | 0.12     | 0.15     | $\Omega$      |
| Drain-Source on-state resistance<br>$V_{GS} = 10\text{ V}$ , $I_D = 2.6\text{ A}$  | $R_{DS(on)}$  | -      | 0.07     | 0.09     |               |

<sup>1</sup>Device on 50mm\*50mm\*1.5mm epoxy PCB FR4 with 6cm<sup>2</sup> (one layer, 70  $\mu\text{m}$  thick) copper area for drain connection. PCB is vertical without blown air.

**Electrical Characteristics, at  $T_j = 25\text{ °C}$ , unless otherwise specified**

| Parameter  | Symbol       | Values |      |      | Unit |
|--|--------------|--------|------|------|------|
|  |              | min.   | typ. | max. |      |
| <b>Dynamic Characteristics</b>   |              |        |      |      |      |
| Transconductance<br>$V_{DS} \geq 2 \cdot I_D \cdot R_{DS(on)max}$ , $I_D = 2.6\text{ A}$                               | $g_{fs}$     | 2.4    | 5.5  | -    | S    |
| Input capacitance<br>$V_{GS} = 0\text{ V}$ , $V_{DS} = 25\text{ V}$ , $f = 1\text{ MHz}$                               | $C_{iss}$    | -      | 300  | 380  | pF   |
| Output capacitance<br>$V_{GS} = 0\text{ V}$ , $V_{DS} = 25\text{ V}$ , $f = 1\text{ MHz}$                              | $C_{oss}$    | -      | 90   | 120  |      |
| Reverse transfer capacitance<br>$V_{GS} = 0\text{ V}$ , $V_{DS} = 25\text{ V}$ , $f = 1\text{ MHz}$                    | $C_{rss}$    | -      | 50   | 65   |      |
| Turn-on delay time<br>$V_{DD} = 30\text{ V}$ , $V_{GS} = 4.5\text{ V}$ , $I_D = 2.6\text{ A}$ ,<br>$R_G = 16\ \Omega$  | $t_{d(on)}$  | -      | 12   | 20   | ns   |
| Rise time<br>$V_{DD} = 30\text{ V}$ , $V_{GS} = 4.5\text{ V}$ , $I_D = 2.6\text{ A}$ ,<br>$R_G = 16\ \Omega$           | $t_r$        | -      | 15   | 25   |      |
| Turn-off delay time<br>$V_{DD} = 30\text{ V}$ , $V_{GS} = 4.5\text{ V}$ , $I_D = 2.6\text{ A}$ ,<br>$R_G = 16\ \Omega$ | $t_{d(off)}$ | -      | 20   | 30   |      |
| Fall time<br>$V_{DD} = 30\text{ V}$ , $V_{GS} = 4.5\text{ V}$ , $I_D = 2.6\text{ A}$ ,<br>$R_G = 16\ \Omega$           | $t_f$        | -      | 15   | 25   |      |

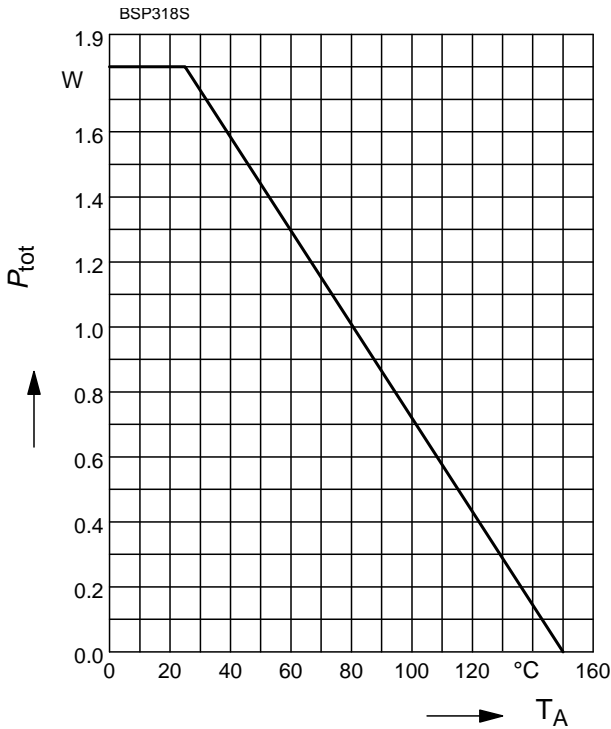
**Electrical Characteristics, at  $T_j = 25\text{ °C}$ , unless otherwise specified**

| Parameter   | Symbol          | Values |      |      | Unit |
|---|-----------------|--------|------|------|------|
|   |                 | min.   | typ. | max. |      |
| <b>Dynamic Characteristics</b>  |                 |        |      |      |      |
| Gate charge at threshold<br>$V_{DD} = 40\text{ V}$ , $I_D = 0.1\text{ A}$ , $V = 1\text{ V}$                              | $Q_{G(th)}$     | -      | 0.4  | 0.6  | nC   |
| Gate charge at $V_{GS} = 5\text{ V}$<br>$V_{DD} = 40\text{ V}$ , $I_D = 2.6\text{ A}$ , $V_{GS} = 0\text{ to }5\text{ V}$ | $Q_{g(5)}$      | -      | 7    | 10   |      |
| Gate charge total<br>$V_{DD} = 40\text{ V}$ , $I_D = 2.6\text{ A}$ , $V_{GS} = 0\text{ to }10\text{ V}$                   | $Q_g$           | -      | 14   | 20   |      |
| Gate plateau voltage<br>$V_{DD} = 40\text{ V}$ , $I_D = 2.6\text{ A}$   | $V_{(plateau)}$ | -      | 3.6  | -    | V    |

| Parameter   | Symbol   | Values |      |      | Unit          |
|---|----------|--------|------|------|---------------|
|   |          | min.   | typ. | max. |               |
| <b>Reverse Diode</b>  |          |        |      |      |               |
| Inverse diode continuous forward current<br>$T_A = 25\text{ °C}$                                    | $I_S$    | -      | -    | 2.6  | A             |
| Inverse diode direct current,pulsed<br>$T_A = 25\text{ °C}$   | $I_{SM}$ | -      | -    | 10.4 |               |
| Inverse diode forward voltage<br>$V_{GS} = 0\text{ V}$ , $I_F = 5.2\text{ A}$                       | $V_{SD}$ | -      | 0.95 | 1.2  | V             |
| Reverse recovery time<br>$V_R = 30\text{ V}$ , $I_F = I_S$ , $di_F/dt = 100\text{ A}/\mu\text{s}$   | $t_{rr}$ | -      | 50   | 75   | ns            |
| Reverse recovery charge<br>$V_R = 30\text{ V}$ , $I_F = I_S$ , $di_F/dt = 100\text{ A}/\mu\text{s}$ | $Q_{rr}$ | -      | 0.1  | 0.15 | $\mu\text{C}$ |

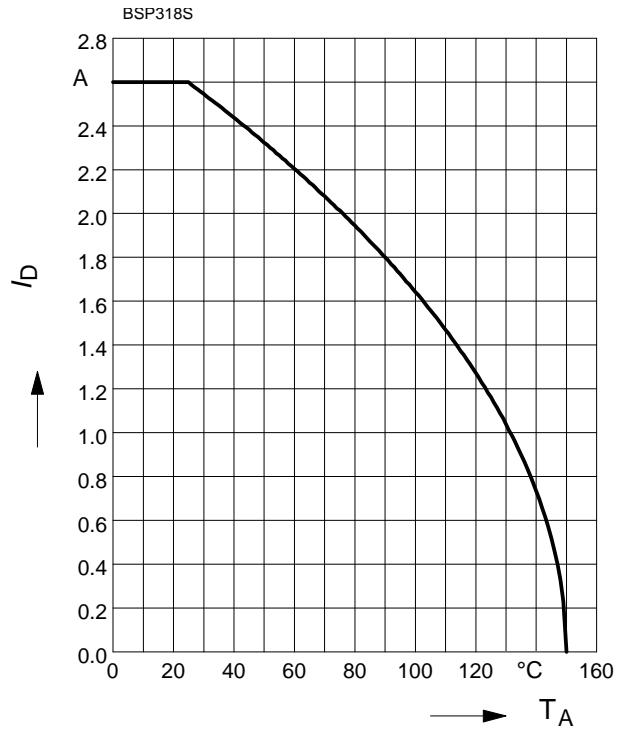
**Power Dissipation**

$$P_{tot} = f(T_A)$$



**Drain current**

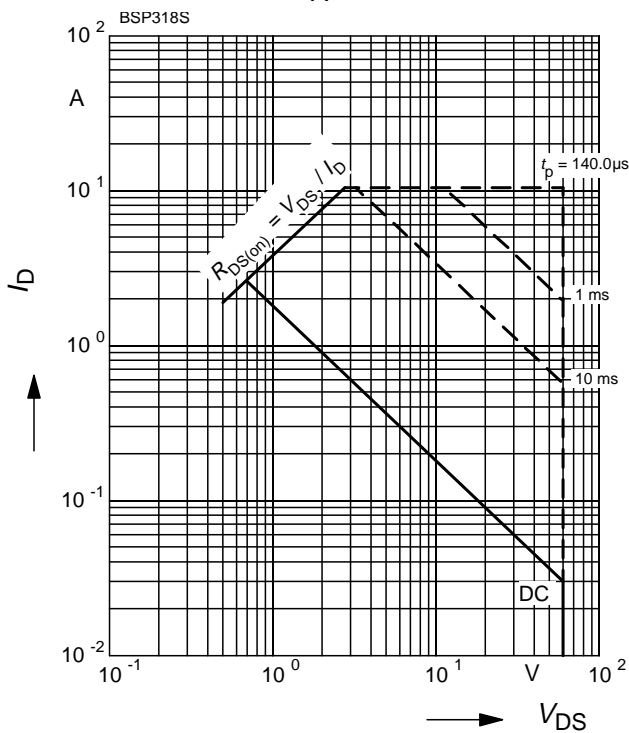
$$I_D = f(T_A)$$



**Safe operating area**

$$I_D = f(V_{DS})$$

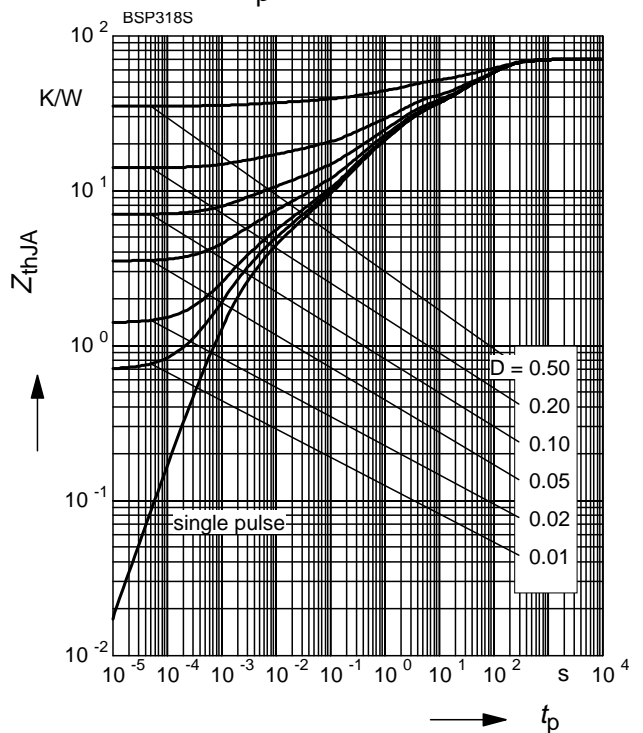
parameter :  $D = 0$  ,  $T_A = 25\text{ °C}$



**Transient thermal impedance**

$$Z_{thJA} = f(t_p)$$

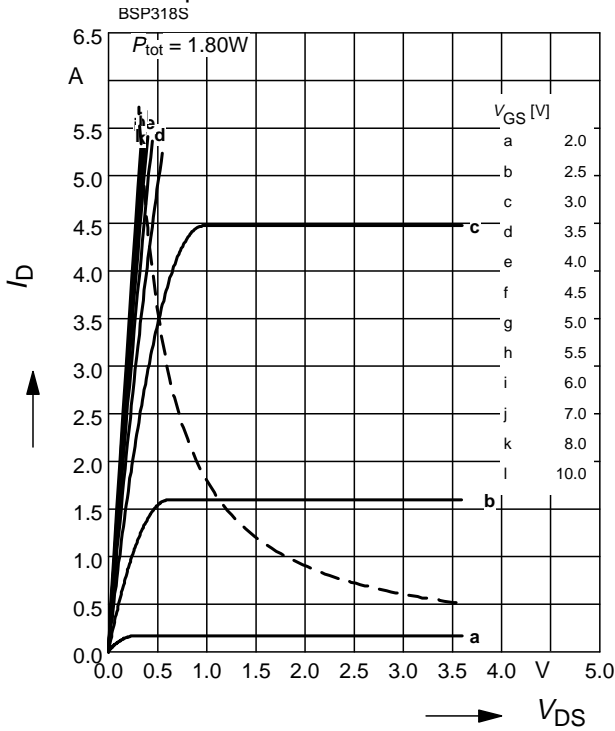
parameter :  $D = t_p/T$



**Typ. output characteristic**

$I_D = f(V_{DS}); T_j = 25^\circ\text{C}$

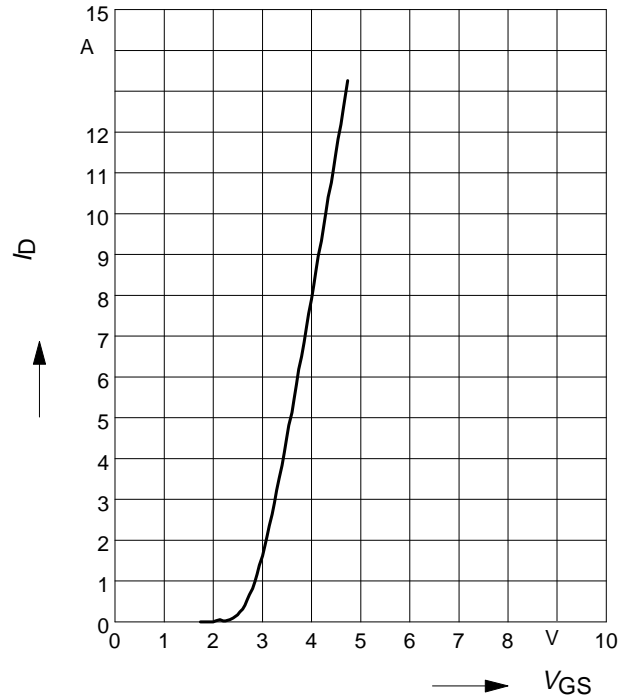
parameter:  $t_p = 80 \mu\text{s}$



**Typ. transfer characteristics  $I_D = f(V_{GS})$**

$V_{DS} \geq 2 \times I_D \times R_{DS(on)max}$

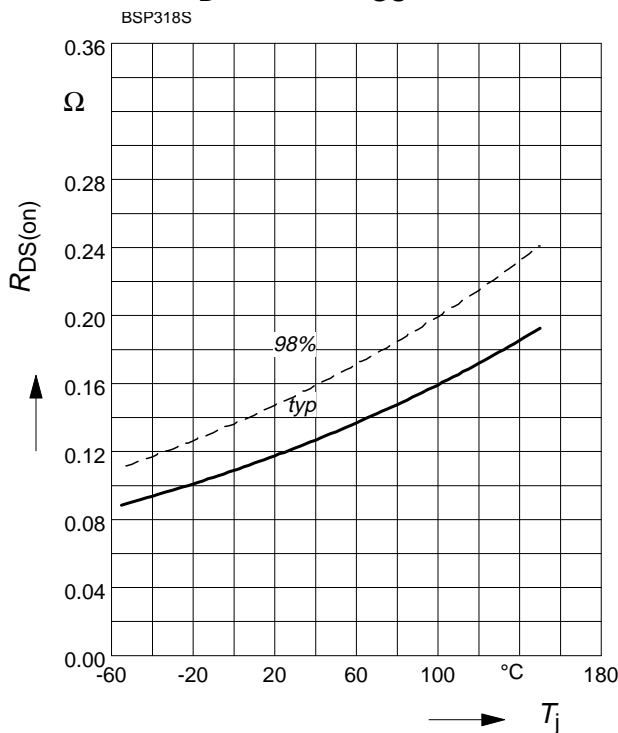
parameter:  $t_p = 80 \mu\text{s}$



**Drain-source on-resistance**

$R_{DS(on)} = f(T_j)$

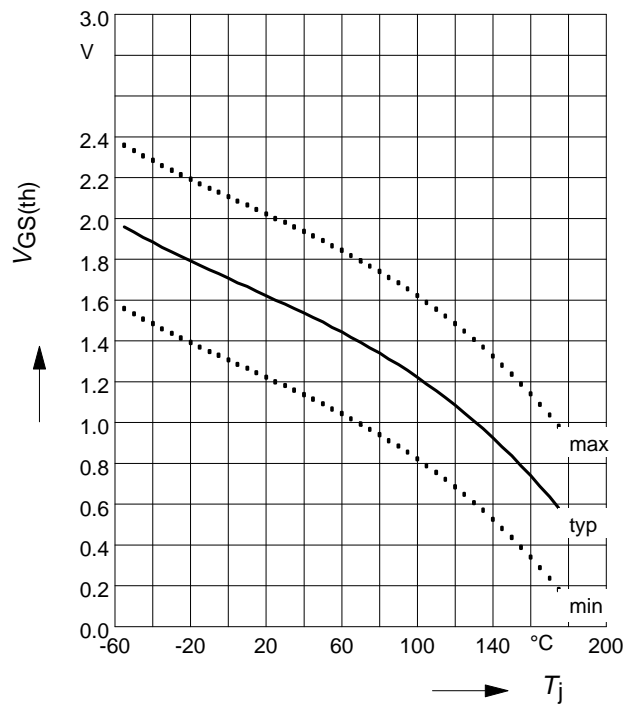
parameter:  $I_D = 2.6 \text{ A}, V_{GS} = 4.5 \text{ V}$



**Gate threshold voltage**

$V_{GS(th)} = f(T_j)$

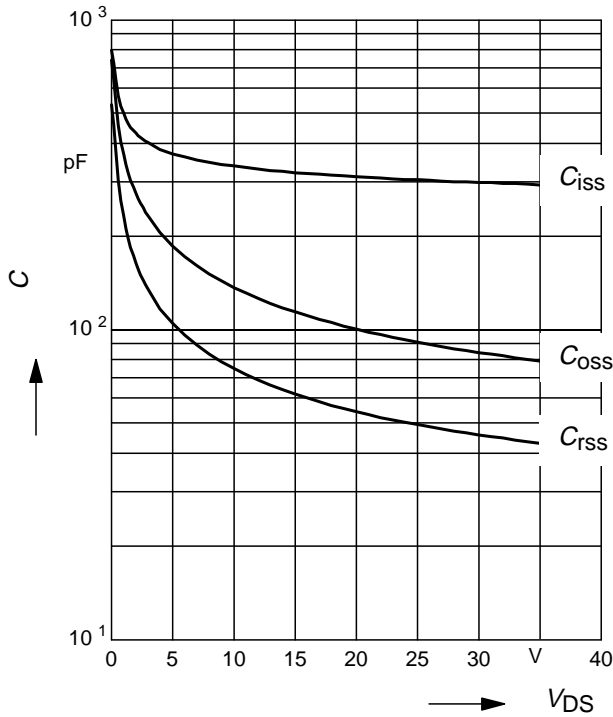
parameter:  $V_{GS} = V_{DS}, I_D = 20 \mu\text{A}$



**Typ. capacitances**

$C = f(V_{DS})$

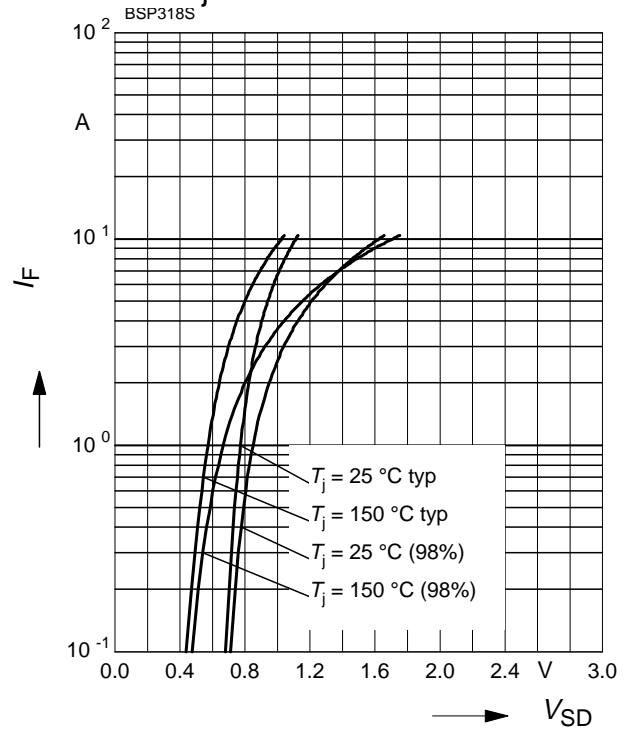
parameter:  $V_{GS}=0\text{ V}$ ,  $f=1\text{ MHz}$



**Forward characteristics of reverse diode**

$I_F = f(V_{SD})$

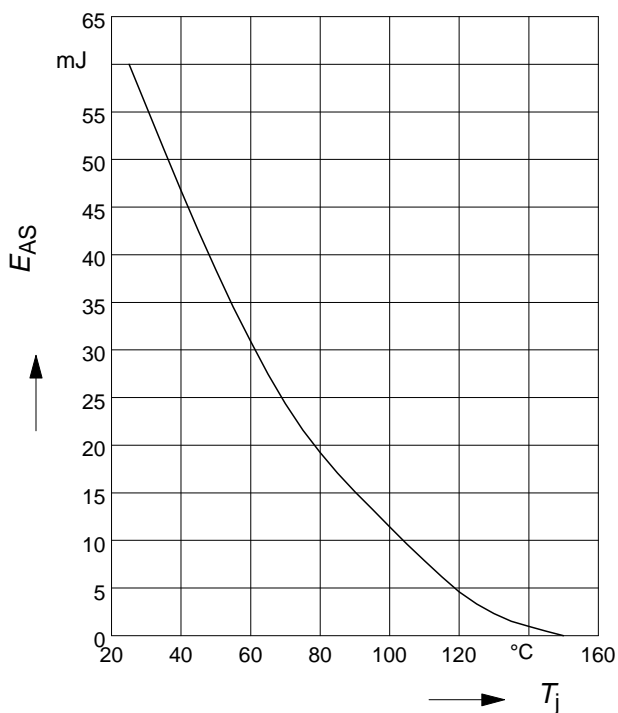
parameter:  $T_j$ ,  $t_p = 80\ \mu\text{s}$



**Avalanche Energy  $E_{AS} = f(T_j)$**

parameter:  $I_D = 2.6\text{ A}$ ,  $V_{DD} = 25\text{ V}$

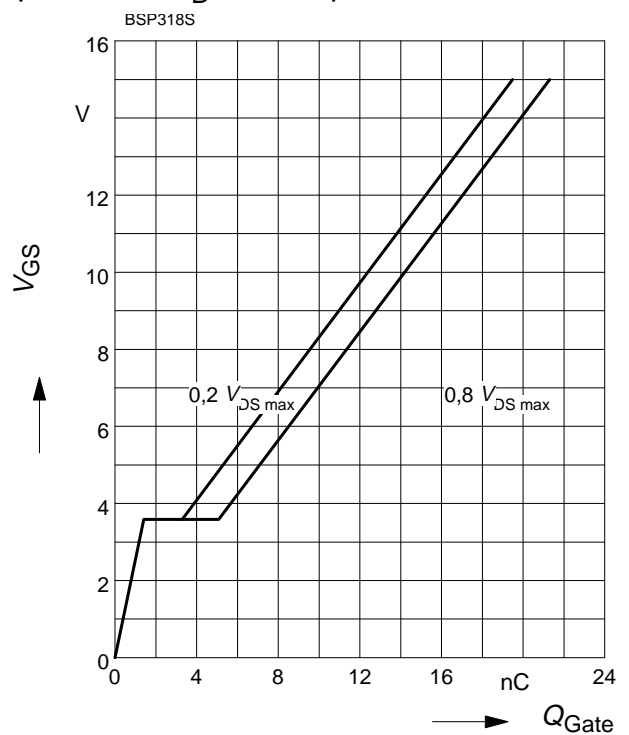
$R_{GS} = 25\ \Omega$



**Typ. gate charge**

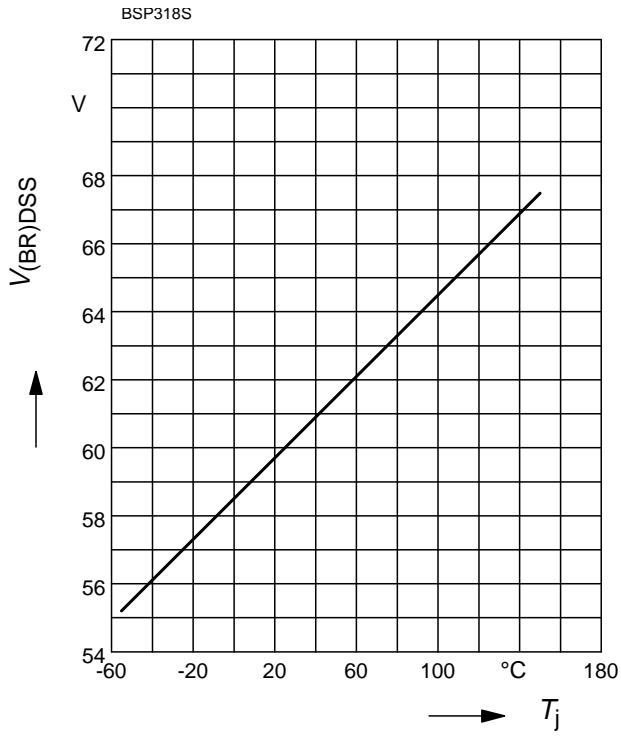
$V_{GS} = f(Q_{Gate})$

parameter:  $I_D = 2.6\text{ A pulsed}$



Drain-source breakdown voltage

$$V_{(BR)DSS} = f(T_j)$$



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